

<b>Notice of References Cited</b>	Application/Control No. 10/075,065	Applicant(s)/Patent Under Reexamination MOSER ET AL.	
	Examiner Neveen Abel-Jalil	Art Unit 2165	Page 1 of 1

**U.S. PATENT DOCUMENTS**

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	M	US-			

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**NON-PATENT DOCUMENTS**

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	U	Fasn Zhang and Andrew K.S. Jardine. Optimal Maintenance models with minimal repair, periodic overhaul and complete renewal. IIE Transactions (July 1998).
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.